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OPA859

#### SBOS852-SEPTEMBER 2018

# OPA859 1.8 GHz Unity-Gain Bandwidth, 3.3-nV/VHz, FET Input Amplifier

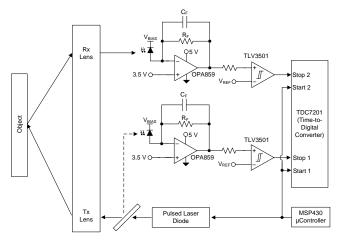
## 1 Features

- High Unity-Gain Bandwidth: 1.8 GHz
- Gain Bandwidth Product: 900 MHz
- Ultra-Low Bias Current MOSFET Inputs: 10 pA
- Low Input Voltage Noise: 3.3 nV/√Hz
- Slew Rate: 1150 V/µs
- Low Input Capacitance:
  - Common-Mode: 0.6 pF
  - Differential: 0.2 pF
- Wide Input Common-Mode Range:
  - 1.4 V from Positive Supply
  - Includes Negative Supply
- 2.5 V<sub>PP</sub> Output Swing in TIA Configuration
- Supply Voltage Range: 3.3 V to 5.25 V
- Quiescent Current: 20.5 mA
- Package: 8-Pin WSON
- Temperature Range: –40 to +125°C

# 2 Applications

- High-Speed Transimpedance Amplifier
- Laser Distance Measurement
- CCD Output Buffer
- High-Speed Buffer
- Optical Time Domain Reflectometry (OTDR)
- High-Speed Active Filter
- 3D Scanner
- Silicon Photomultiplier (SiPM) Buffer Amplifier
- Photomultiplier Tube Post Amplifier

## High-Speed Time-of-Flight Receiver



# 3 Description

The OPA859 is a wideband, low-noise operational amplifier with CMOS inputs for wideband transimpedance and voltage amplifier applications. When the device is configured as a transimpedance amplifier (TIA), the 0.9-GHz gain bandwidth product (GBWP) enables high closed-loop bandwidths in low-capacitance photodiode applications.

The graph below shows the bandwidth and noise performance of the OPA859 as a function of the photodiode capacitance when the amplifier is set as a TIA. The total noise is calculated along a bandwidth range extending from dc to the calculated frequency, f, on the left-hand scale. The OPA859 package has a feedback pin (FB) that simplifies the feedback network connection between the input and the output.

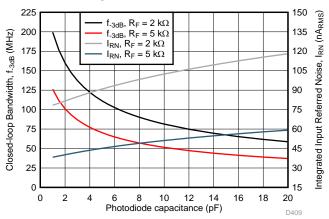
The OPA859 is optimized to operate in optical timeof-flight (ToF) systems where the OPA859 is used with time-to-digital converters, such as the TDC7201. Use the OPA859 to drive a high-speed analog-todigital converter (ADC) in high-resolution LIDAR systems with a differential output amplifier, such as the THS4541 or LMH5401.

### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
OPA859	WSON (8)	2.00 mm × 2.00 mm

(1) For all available packages, see the package option addendum at the end of the data sheet.

#### Photodiode Capacitance vs Bandwidth and Noise



An IMPORT

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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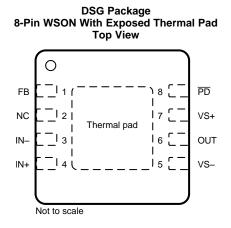
# 4 Revision History

DATE	REVISION	NOTES
September 2018	*	Initial release.

# 5 Device Comparison Table

DEVICE	INPUT TYPE	MINIMUM STABLE GAIN	VOLTAGE NOISE (nV/√Hz)	INPUT CAPACITANCE (pF)	GAIN BANDWIDTH (GHz)
OPA859	CMOS	1 V/V	3.3	0.8	0.9
OPA858	CMOS	7 V/V	2.5	0.8	5.5
OPA855	Bipolar	7 V/V	0.98	0.8	8
LMH6629	Bipolar	10 V/V	0.69	5.7	4

# 6 Pin Configuration and Functions



#### **Pin Functions**

PIN		10	DESCRIPTION
NAME	NO.	I/O	DESCRIPTION
FB	1	I	Feedback connection to output of amplifier
IN–	3	I	Inverting input
IN+	4	Ι	Noninverting input
NC	2	_	Do not connect
OUT	6	0	Amplifier output
PD	8	I	Power down connection. $\overline{PD}$ = logic low = power off mode; $\overline{PD}$ = logic high = normal operation.
VS-	5		Negative voltage supply
VS+	7	—	Positive voltage supply
Thermal pad		_	Connect the thermal pad to VS-

## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>S</sub>	Total supply voltage (V <sub>S+</sub> – V <sub>S-</sub> )		5.5	V
V <sub>IN+</sub> , V <sub>IN-</sub>	Input voltage	(V <sub>S</sub> _) – 0.5	$(V_{S+}) + 0.5$	V
V <sub>ID</sub>	Differential input voltage		1	V
V <sub>OUT</sub>	Output voltage	(V <sub>S</sub> _) – 0.5	$(V_{S+}) + 0.5$	V
I <sub>IN</sub>	Continuous input current		±10	mA
I <sub>OUT</sub>	Continuous output current <sup>(2)</sup>		±100	mA
TJ	Junction temperature		150	°C
T <sub>A</sub>	Operating free-air temperature	-40	125	°C
T <sub>stg</sub>	Storage temperature	-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Long-term continuous output current for electromigration limits.

## 7.2 ESD Ratings

			VALUE	UNIT
V	Electrostatia discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±1000	V
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1500	v

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

## 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Vs	Total supply voltage ( $V_{S+} - V_{S-}$ )	3.3	5	5.25	V
T <sub>A</sub>	Operating free-air temperature	-40		125	°C

#### 7.4 Thermal Information

		OPA859	
	THERMAL METRIC <sup>(1)</sup>	DSG (WSON)	UNIT
		8 PINS	
$R_{ ext{ heta}JA}$	Junction-to-ambient thermal resistance	80.1	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	100	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	45	°C/W
ΨJT	Junction-to-top characterization parameter	6.8	°C/W
ΨЈВ	Junction-to-board characterization parameter	45.2	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	22.7	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

### 7.5 Electrical Characteristics

 $V_{S+} = 5 \text{ V}, V_{S-} = 0 \text{ V}$ , input common-mode biased at midsupply, unity gain configuration,  $R_L = 200 \Omega$ , output load is referenced to midsupply, and  $T_A \approx +25^{\circ}$ C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
AC PERFO	RMANCE					
SSBW	Small-signal bandwidth	$V_{OUT} = 100 \text{ mV}_{PP}$		1.8		GHz
LSBW	Large-signal bandwidth	$V_{OUT} = 2 V_{PP}$		400		MHz
GBWP	Gain-bandwidth product			900		MHz
	Bandwidth for 0.1dB flatness			140		MHz
SR	Slew rate (10% - 90%)	V <sub>OUT</sub> = 2-V step		1150		V/µs
t <sub>r</sub>	Rise time	V <sub>OUT</sub> = 100-mV step		0.3		ns
t <sub>f</sub>	Fall time	V <sub>OUT</sub> = 100-mV step		0.3		ns
<u>.</u>	Settling time to 0.1%	V <sub>OUT</sub> = 2-V step		8		ns
	Settling time to 0.001%	V <sub>OUT</sub> = 2-V step		3000		ns
	Overshoot/undershoot	V <sub>OUT</sub> = 2-V step		7%		
		$f = 10 \text{ MHz}, V_{OUT} = 2 V_{PP}$		90		
HD2	Second-order harmonic distortion	$f = 100 \text{ MHz}, V_{OUT} = 2 V_{PP}$		60		dBc
		$f = 10 \text{ MHz}, V_{OUT} = 2 V_{PP}$		86		dBc
HD3	Third-order harmonic distortion	$f = 100 \text{ MHz}, V_{OUT} = 2 V_{PP}$		64		dBc
en	Input-referred voltage noise	f = 1 MHz		3.3		nV/√Hz
Z <sub>OUT</sub>	Closed-loop output impedance	f = 1 MHz		0.15		Ω
DC PERFO						
A <sub>OL</sub>	Open-loop voltage gain		60	65		dB
V <sub>OS</sub>	Input offset voltage	T <sub>A</sub> = 25°C	-5	±0.9	5	mV
$\Delta V_{OS} / \Delta T$	Input offset voltage drift	$T_A = -40^{\circ}C$ to +125°C		-2	0	μV/°C
I <sub>BN</sub> , I <sub>BI</sub>	Input bias current	$T_A = 25^{\circ}C$	-5	±0.5	5	<u>р</u> ү, с рА
I <sub>BOS</sub>	Input offset current	$T_{A} = 25^{\circ}C$	5	±0.0 ±0.1	5	рА
CMRR	Common-mode rejection ratio	$V_{CM} = \pm 0.5 V$	70	84	Ũ	dB
INPUT		VCM - 10.3 V	10	04		uВ
	Common-mode input resistance			1		GΩ
C <sub>CM</sub>	Common-mode input resistance			0.62		 pF
ССМ	Differential input resistance			1		GΩ
C	Differential input capacitance			0.2		pF
		V <sub>S+</sub> = 3.3 V, CMRR > 66 dB	1.7	1.9		ρr V
V <sub>IH</sub>	Common-mode input range (high)		1.7	0	0.4	V
V <sub>IL</sub>	Common-mode input range (low)	V <sub>S+</sub> = 3.3 V, CMRR > 66 dB CMRR > 66 dB	2.4		0.4	v
VIH	Common-mode input range (high)		3.4	3.6		V
		$T_A = -40^{\circ}$ C to +125°C, CMRR > 66 dB		3.4	0.4	
V <sub>IL</sub>	Common-mode input range (low)	CMRR > 66 dB		0	0.4	V
		$T_A = -40^{\circ}C$ to +125°C, CMRR > 66 dB		0.35	0.45	
OUTPUT				~ .		
V <sub>OH</sub>	Output voltage (high)	$V_{S+} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$	2.3	2.4		V
V <sub>OH</sub>	Output voltage (high)	TA = 25°C	3.95	4.1		V
		$T_A = -40^{\circ}C \text{ to } +125^{\circ}C$		3.9		
V <sub>OL</sub>	Output voltage (low)	V <sub>S+</sub> = 3.3 V, T <sub>A</sub> = 25°C		1.05	1.15	V
V <sub>OL</sub>	Output voltage (low)	$T_A = 25^{\circ}C$		1.1	1.15	V
UL		$T_A = -40^{\circ}C$ to $+125^{\circ}C$		1.2		-
		R <sub>L</sub> = 10 Ω, A <sub>OL</sub> > 52 dB	65	76		
I <sub>O_LIN</sub>	Linear output drive (sink and source)	$T_A = -40^{\circ}$ C to +125°C, $R_L = 10 \Omega$ , $A_{OL} > 52 dB$		64		mA
I <sub>SC</sub>	Output short-circuit current		85	105		mA



## **Electrical Characteristics (continued)**

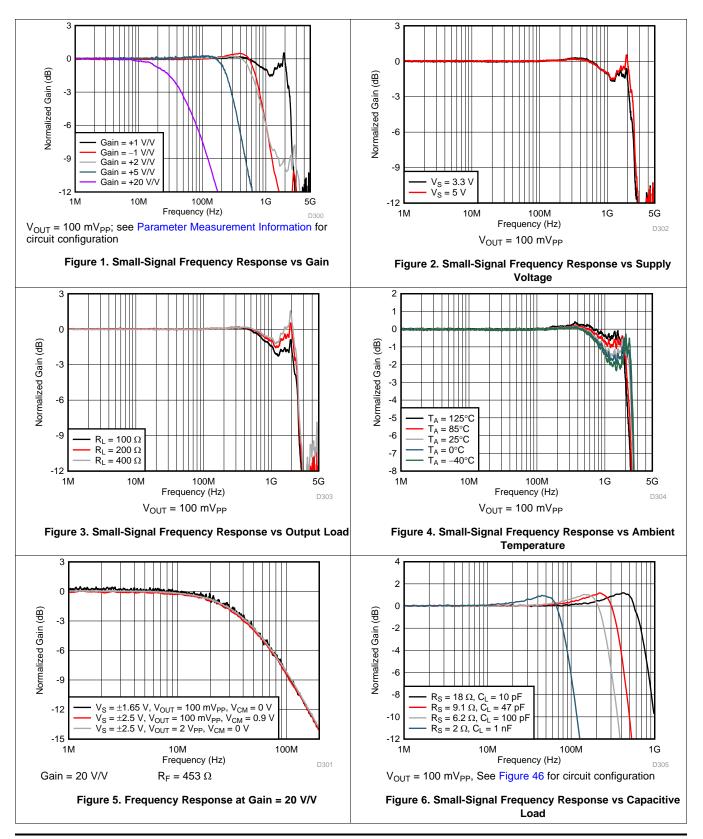
 $V_{S+} = 5 \text{ V}, V_{S-} = 0 \text{ V}$ , input common-mode biased at midsupply, unity gain configuration,  $R_L = 200 \Omega$ , output load is referenced to midsupply, and  $T_A \approx +25^{\circ}$ C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER S	UPPLY					
		V <sub>S+</sub> = 5 V	18	20.5	24	
		V <sub>S+</sub> = 3.3 V	17.5	20	23.5	
l <sub>Q</sub>	Quiescent current	V <sub>S+</sub> = 5.25 V	18	21	24	mA
_		$T_A = 125^{\circ}C$		24.5		
		$T_A = -40^{\circ}C$		18.5		
PSRR+	Positive power-supply rejection ratio		66	74		-ID
PSRR-	Negative power-supply rejection ratio		64	72		dB
POWER D	OWN					
	Disable voltage threshold	Amplifier OFF below this voltage	0.65	1		V
	Enable voltage threshold	Amplifier ON above this voltage		1.5	1.8	V
	Power-down quiescent current			70	140	μA
	PD bias current			70	200	μA
	Turnon time delay	Time to $V_{OUT}$ = 90% of final value		25		ns
	Turnoff time delay			120		ns



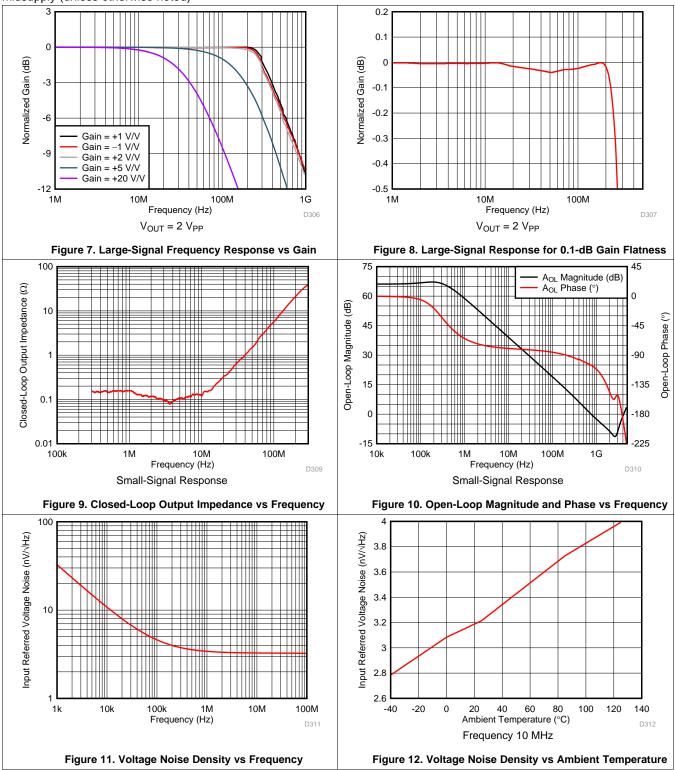
#### 7.6 Typical Characteristics

at  $T_A = 25^{\circ}$ C,  $V_{S+} = 2.5$  V,  $V_{S-} = -2.5$  V,  $V_{IN+} = 0$  V, Gain = 1 V/V,  $R_F = 0 \Omega$ ,  $R_L = 200 \Omega$ , and output load referenced to midsupply (unless otherwise noted)



## **Typical Characteristics (continued)**

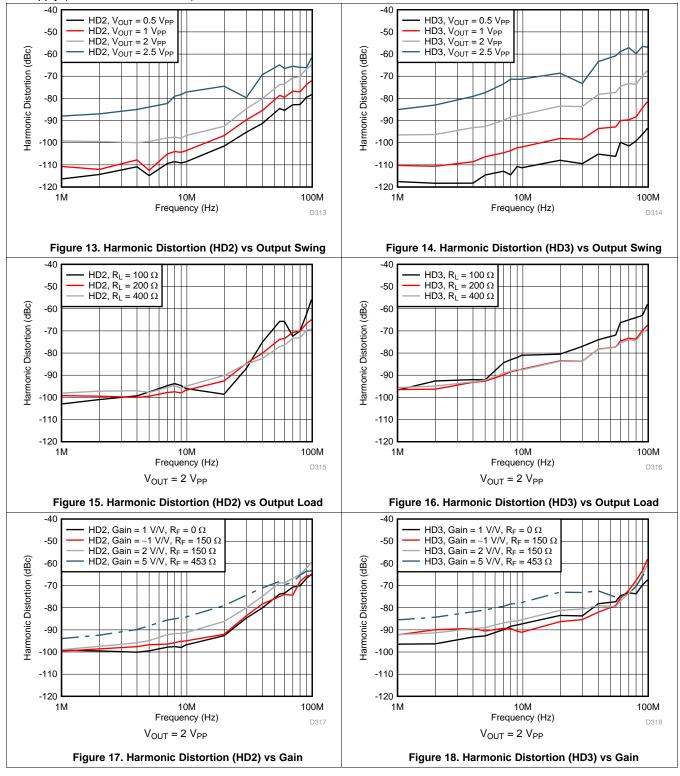
at  $T_A = 25^{\circ}$ C,  $V_{S+} = 2.5$  V,  $V_{S-} = -2.5$  V,  $V_{IN+} = 0$  V, Gain = 1 V/V,  $R_F = 0 \Omega$ ,  $R_L = 200 \Omega$ , and output load referenced to midsupply (unless otherwise noted)

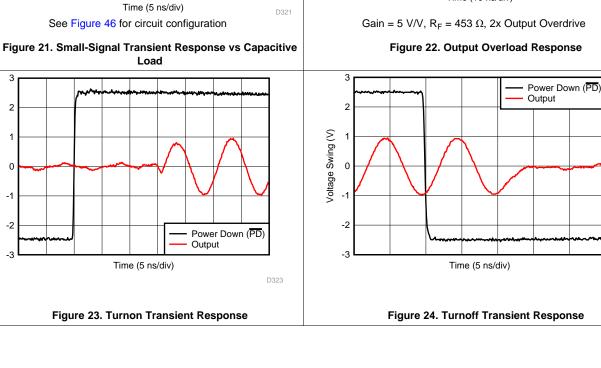




#### **Typical Characteristics (continued)**

at  $T_A = 25^{\circ}$ C,  $V_{S+} = 2.5$  V,  $V_{S-} = -2.5$  V,  $V_{IN+} = 0$  V, Gain = 1 V/V,  $R_F = 0 \Omega$ ,  $R_L = 200 \Omega$ , and output load referenced to midsupply (unless otherwise noted)





60

40

20

0

-20

-40

-60

0.075

0.05

0.025

-0.025

-0.05

-0.075

3

2

1

0

-1

-2

-3

Voltage Swing (V)

0

Voltage Swing (mV)

Voltage Swing (mV)

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RUMENTS

XAS

Input

Time (5 ns/div)

Figure 20. Large-Signal Transient Response

Time (10 ns/div)

Slew Rate: Falling = 1160 V/µs, Rising = 1400 V/µs

Output

## Typical Characteristics (continued)

Input

Output

Time (5 ns/div)

Figure 19. Small-Signal Transient Response

 $R_{S} = 18 \Omega, C_{L} = 10 pF$ 

 $R_{S} = 9.1 \Omega, C_{L} = 47 \text{ pF}$ 

 $R_{\rm S} = 6.2 \ \Omega, \ C_{\rm L} = 100 \ \rm pF$ 

 $R_S = 2 \Omega$ ,  $C_L = 1 nF$ 

Average Rise and Fall Time (10% - 90%) = 450 ps

at  $T_A = 25^{\circ}C$ ,  $V_{S+} = 2.5$  V,  $V_{S-} = -2.5$  V,  $V_{IN+} = 0$  V, Gain = 1 V/V,  $R_F = 0 \Omega$ ,  $R_L = 200 \Omega$ , and output load referenced to midsupply (unless otherwise noted)

1.25

0.75

0.5

0.25

0 -0.25

-0.5 -0.75

-1

-1.25

4 3

2

1 0

-1

-2

-3

-4

Voltage Swing (V)

Voltage Swing (V)

D324

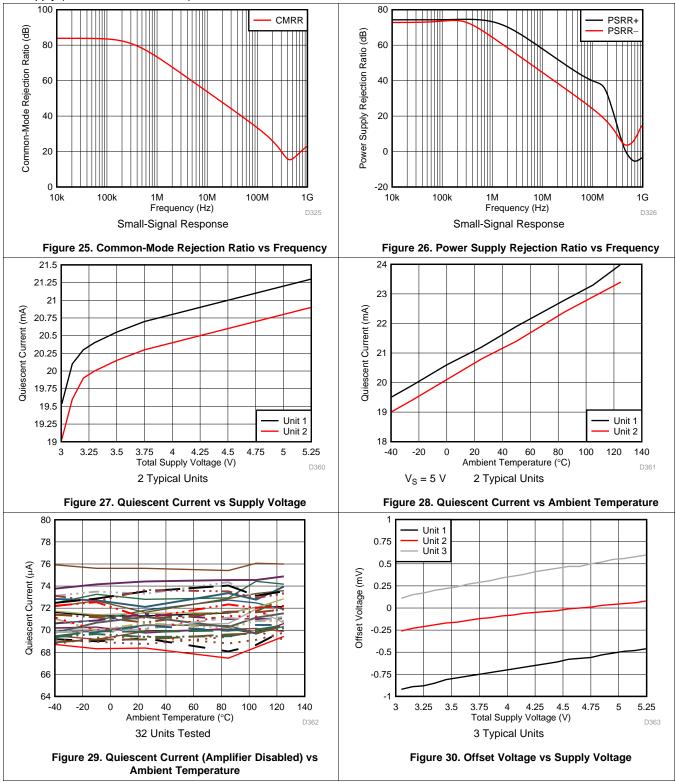
Ideal Output

Measured Output

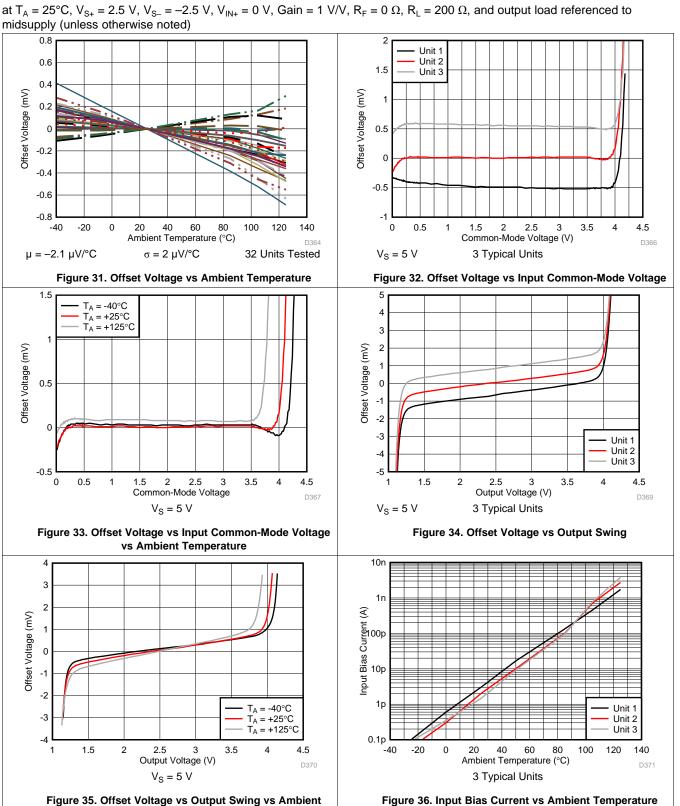


#### **Typical Characteristics (continued)**

at  $T_A = 25^{\circ}$ C,  $V_{S+} = 2.5$  V,  $V_{S-} = -2.5$  V,  $V_{IN+} = 0$  V, Gain = 1 V/V,  $R_F = 0 \Omega$ ,  $R_L = 200 \Omega$ , and output load referenced to midsupply (unless otherwise noted)





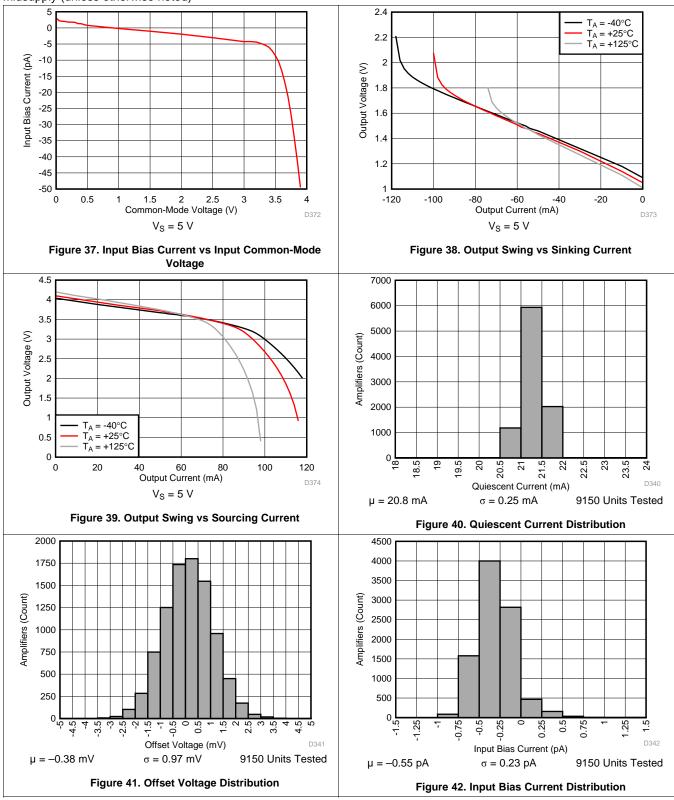






#### **Typical Characteristics (continued)**

at  $T_A = 25^{\circ}$ C,  $V_{S+} = 2.5$  V,  $V_{S-} = -2.5$  V,  $V_{IN+} = 0$  V, Gain = 1 V/V,  $R_F = 0 \Omega$ ,  $R_L = 200 \Omega$ , and output load referenced to midsupply (unless otherwise noted)





#### Parameter Measurement Information 8

GND

50 Ω

 $\wedge \wedge \wedge$ 

50-Ω

50 Ω

≤ 50 Ω

#### 8.1 **Parameter Measurement Information**

50-Ω

Source

The various test setup configurations for the OPA859 are shown in the figures below. When configuring the OPA859 as a noninverting amplifier in gains less 3 V/V, set  $R_F = 150 \Omega$ . When configuring the OPA859 as a noninverting amplifier in gains of 4 V/V and greater, set  $R_F = 453 \Omega$ .

2.5 V

-2.5 V

169 Ω

71.5 Ω ≷

GND

50-Ω Measurement

System

50-Ω

Measurement

System

50 Ω

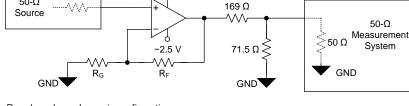
GND

50 Ω

GND

Figure 43. Unity-Gain Buffer Configuration

2.5 V



169 Ω

71.5 Ω ≥

GND

R<sub>G</sub> values depend on gain configuration

GND

₹

75 Ω

GND

 $\Lambda \Lambda \Lambda$ 

150 Ω

50 O



2.5 V

P

-2.5 V

 $\sqrt{N}$ 

150 Ω

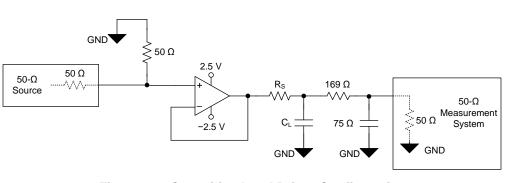


Figure 45. Inverting Configuration (Gain = -1 V/V)

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## 9 Detailed Description

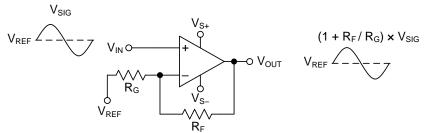
## 9.1 Overview

The ultra-wide, 900-MHz gain bandwidth product (GBWP) of the OPA859, combined with the broadband voltage noise of 3.3 nV/ $\sqrt{Hz}$ , produces a viable amplifier for wideband transimpedance applications, high-speed data acquisition systems, and applications with weak signal inputs that require low-noise and high-gain front ends. The OPA859 combines multiple features to optimize dynamic performance. In addition to the wide small-signal bandwidth, the OPA859 has 400 MHz of large-signal bandwidth (V<sub>OUT</sub> = 2 V<sub>PP</sub>), and a slew rate of 1150 V/µs.

The OPA859 is offered in a 2-mm × 2-mm, 8-pin WSON package that features a feedback (FB) pin for a simple feedback network connection between the amplifiers output and inverting input. Excess capacitance on an amplifiers input pin can reduce phase margin causing instability. This problem is exacerbated in the case of very wideband amplifiers like the OPA859. To reduce the effects of stray capacitance on the input node, the OPA859 pinout features an isolation pin (NC) between the feedback and inverting input pins that increases the physical spacing between them thereby reducing parasitic coupling at high frequencies. The OPA859 also features a very low capacitance input stage with only 0.8-pF of total input capacitance.

# 9.2 Functional Block Diagram

The OPA859 is a classic, voltage feedback operational amplifier (op amp) with two high-impedance inputs and a low-impedance output. Standard application circuits are supported, like the two basic options shown in Figure 47 and Figure 48. The DC operating point for each configuration is level-shifted by the reference voltage ( $V_{REF}$ ), which is typically set to midsupply in single-supply operation.  $V_{REF}$  is typically connected to ground in split-supply applications.



## Figure 47. Noninverting Amplifier

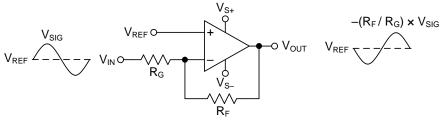


Figure 48. Inverting Amplifier

#### 9.3 Feature Description

#### 9.3.1 Input and ESD Protection

The OPA859 is fabricated on a low-voltage, high-speed, BiCMOS process. The internal, junction breakdown voltages are low for these small geometry devices, and as a result, all device pins are protected with internal ESD protection diodes to the power supplies as Figure 49 shows. There are two antiparallel diodes between the inputs of the amplifier that clamp the inputs during an overrange or fault condition.

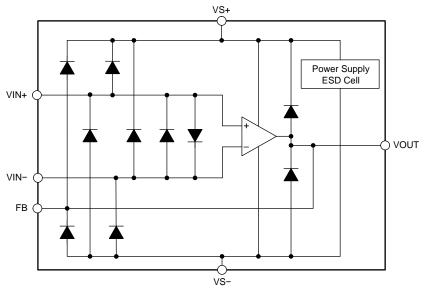


Figure 49. Internal ESD Structure

#### 9.3.2 Feedback Pin

The OPA859 pin layout is optimized to minimize parasitic inductance and capacitance, which is critical in highspeed analog design. The FB pin (pin 1) is internally connected to the output of the amplifier. The FB pin is separated from the inverting input of the amplifier (pin 3) by a no connect (NC) pin (pin 2). The NC pin must be left floating. There are two advantages to this pin layout:

- 1. A feedback resistor (R<sub>F</sub>) can connect between the FB and IN– pin on the same side of the package (see Figure 50) rather than going around the package.
- 2. The isolation created by the NC pin minimizes the capacitive coupling between the FB and IN– pins by increasing the physical separation between the pins.

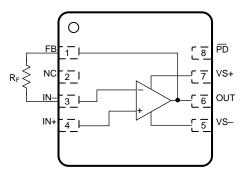


Figure 50. R<sub>F</sub> Connection Between FB and IN– Pins

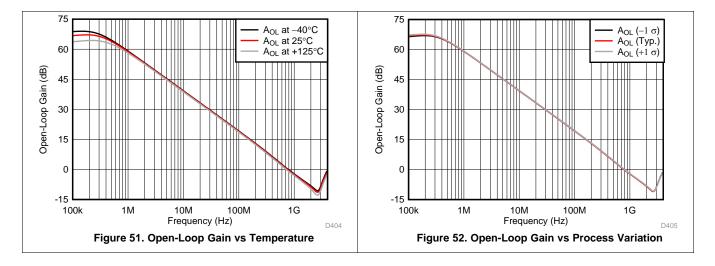


#### Feature Description (continued)

#### 9.3.3 Wide Gain-Bandwidth Product

Figure 10 shows the open-loop magnitude and phase response of the OPA859. Calculate the gain bandwidth product of any op amp by determining the frequency at which the  $A_{OL}$  is 40 dB and multiplying that frequency by a factor of 100. The open-loop response shows the OPA859 to have approximately 63° of phase-margin when configured as a unity-gain buffer.

Figure 51 shows the open-loop magnitude ( $A_{OL}$ ) of the OPA859 as a function of temperature. The results show approximately 5° of phase-margin variation over the entire temperature range. Semiconductor process variation is the naturally occurring variation in the attributes of a transistor (Early-voltage,  $\beta$ , channel-length and width) and other passive elements (resistors and capacitors) when fabricated into an integrated circuit. The process variation can occur across devices on a single wafer, or, across devices over multiple wafer lots over time. Typically the variation across a single wafer is tightly controlled. Figure 52 shows the  $A_{OL}$  magnitude of the OPA859 as a function of process variation over time. The results show the  $A_{OL}$  curve for the nominal process corner and the variation one standard deviation from the nominal. The simulated results show less than 2° of phase-margin difference within a standard deviation of process variation when the amplifier is configured as a unity-gain bufffer.





#### Feature Description (continued)

#### 9.3.4 Slew Rate and Output Stage

In addition to wide bandwidth, the OPA859 features a high slew rate of 1150 V/µs. The slew rate is a critical parameter in high-speed pulse applications with narrow sub-10-ns pulses, such as optical time-domain reflectometry (OTDR) and LIDAR. The high slew rate of the OPA859 implies that the device accurately reproduces a 2-V, sub-ns pulse edge, as seen in Figure 20. The wide bandwidth and slew rate of the OPA859 make it an excellent amplifier for high-speed, signal-chain front ends.

Figure 53 shows the open-loop output impedance of the OPA859 as a function of frequency. To achieve high slew rates and low output impedance across frequency, the output swing of the OPA859 is limited to approximately 3 V. The OPA859 is typically used in conjunction with high-speed pipeline ADCs and flash ADCs that have limited input ranges. Therefore, the OPA859 output swing range coupled with the class-leading voltage noise specification for a CMOS amplifier maximizes the overall dynamic range of the signal chain.

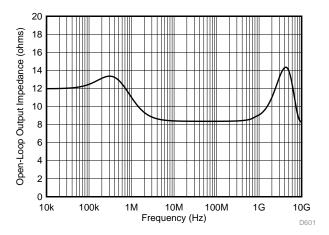


Figure 53. Open-Loop Output Impedance (Z<sub>OL</sub>) vs Frequency

#### 9.3.5 Current Noise

The input impedance of CMOS and JFET input amplifiers at low frequencies exceed several  $G\Omega$ s. However, at higher frequencies, the transistors parasitic capacitance to the drain, source, and substrate reduces the impedance. The high impedance at low frequencies eliminates any bias current and the associated shot noise. At higher frequencies, the input current noise increases (see Figure 54) as a result of capacitive coupling between the CMOS gate oxide and the underlying transistor channel. This phenomenon is a natural artifact of the construction of the transistor and is unavoidable.

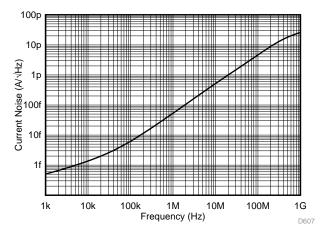


Figure 54. Input Current Noise (I<sub>BN</sub> and I<sub>BI</sub>) vs Frequency



#### 9.4 Device Functional Modes

#### 9.4.1 Split-Supply and Single-Supply Operation

The OPA859 can be configured with single-sided supplies or split-supplies as shown in Figure 60. Split-supply operation using balanced supplies with the input common-mode set to ground eases lab testing because most signal generators, network analyzers, spectrum analyzers, and other lab equipment typically reference inputs and outputs to ground. Split-supply operation is preferred in systems where the signals swing around ground. However, the system requires two supply rails. In split-supply operation, the thermal pad must be connected to the negative supply.

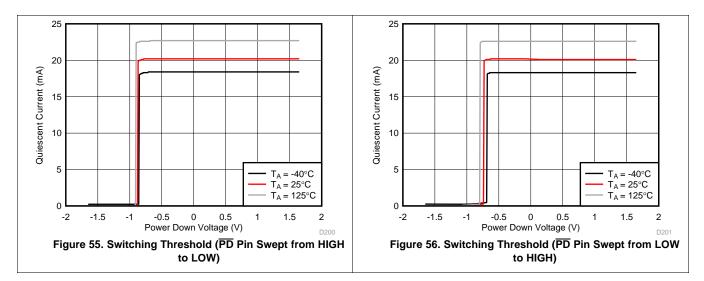
Newer systems use a single power supply to improve efficiency and reduce the cost of the extra power supply. The OPA859 can be used with a single positive supply (negative supply at ground) with no change in performance if the input common-mode and output swing are biased within the linear operation of the device. In single-supply operation, level shift the dc input and output reference voltages by half the difference between the power supply rails. This configuration maintains the input common-mode and output load reference at midsupply. To eliminate gain errors, the source driving the reference input common-mode voltage must have low output impedance across the frequency range of interest . In this case, the thermal pad must be connected to ground.

#### 9.4.2 Power-Down Mode

The OPA859 features a power-down mode to reduce the quiescent current to conserve power. Figure 23 and Figure 24 show the transient response of the OPA859 as the PD pin toggles between the disabled and enabled states.

The  $\overline{PD}$  disable and enable threshold voltages are with reference to the negative supply. If the amplifier is configured with the positive supply at 3.3 V and the negative supply at ground, then the disable and enable threshold voltages are 0.65 V and 1.8 V, respectively. If the amplifier is configured with ±1.65-V supplies, then the disable and enable threshold voltages are at -1 V and 0.15 V, respectively. If the amplifier is configured with ±2.5-V supplies, then the threshold voltages are at -1.85 V and -0.7 V.

Figure 55 shows the switching behavior of a typical amplifier as the PD pin is swept down from the enabled state to the disabled state. Similarly, Figure 56 shows the switching behavior of a typical amplifier as the PD pin is swept up from the disabled state to the enabled state. The small difference in the switching thresholds between the down sweep and the up sweep is caused by the hysteresis designed into the amplifier to increase immunity to noise on the PD pin.



Connecting the  $\overline{PD}$  pin low disables the amplifier and places the output in a high-impedance state. When the amplifier is configured as a noninverting amplifier, the feedback ( $R_F$ ) and gain ( $R_G$ ) resistor network form a parallel load to the output of the amplifier. To protect the input stage of the amplifier, the OPA859 uses internal, back-to-back protection diodes between the inverting and noninverting input pins as Figure 49 shows. In the power-down state, if the differential voltage between the input pins of the amplifier exceeds a diode voltage drop, an additional low-impedance path is created between the noninverting input pin and the output pin.

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### **10** Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

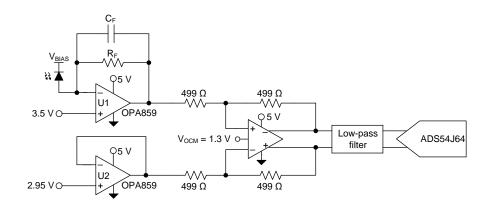
#### **10.1** Application Information

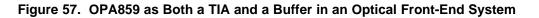
The OPA859 offers high input impedance, very high-bandwidth, high slew-rate, low noise, and better than -60 dBc of distortion performance at frequencies up to 100 MHz. These features make this device an excellent frontend buffer in high-speed data acquisition systems. The wide bandwidth also makes this amplifier an excellent choice for high-gain active filter systems.



#### **10.2 Typical Application**

Figure 57 shows the OPA859 configured as a transimpedance amplifier (U1) in a wide-bandwidth, optical frontend system. A second OPA859 configured as a unity-gain buffer (U2) sets a dc offset voltage to the THS4520. The THS4520 is used to convert the single-ended transimpedance output of the OPA859 into a differential output signal. The THS4520 drives the input of the ADS54J64, 14-bit, 1-GSPS analog-to-digital converter (ADC) that digitizes the analog signal.





#### 10.2.1 Design Requirements

The objective is to design a low noise, wideband optical front-end system using the OPA859 as a transimpedance amplifier. The design requirements are:

- Amplifier supply voltage: 5 V
- TIA common-mode voltage: 3.5 V
- THS4520 gain: 1 V/V
- ADC input common-mode voltage: 1.3 V
- ADC analog differential input range: 1.1 V<sub>PP</sub>

#### 10.2.2 Detailed Design Procedure

The OPA859 meets the growing demand for wideband, low-noise photodiode amplifiers. The closed-loop bandwidth of a transimpedance amplifier is a function of the following:

- 1. The total input capacitance (C<sub>IN</sub>). This total includes the photodiode capacitance, the input capacitance of the amplifier (common-mode and differential capacitance) and any stray capacitance from the PCB.
- 2. The op amp gain bandwidth product (GBWP).
- 3. The transimpedance gain  $(R_F)$ .

Figure 57 shows the OPA859 configured as a TIA, with the avalanche photodiode (APD) reverse biased so that the APD cathode is tied to a large positive bias voltage. In this configuration, the APD sources current into the op amp feedback loop so that the output swings in a negative direction relative to the input common-mode voltage. To maximize the output swing in the negative direction, the OPA859 common-mode voltage is set close to the positive limit; only 1.5 V from the positive supply rail. The feedback resistance ( $R_F$ ) and the input capacitance ( $C_{IN}$ ) form a zero in the noise gain that results in instability if left unchecked. To counteract the effect of the zero, a pole is inserted into the noise gain transfer function by adding the feedback capacitor ( $C_F$ ).

The *Transimpedance Considerations for High-Speed Amplifiers Application Report* discusses theories and equations that show how to compensate a transimpedance amplifier for a particular transimpedance gain and input capacitance. The bandwidth and compensation equations from the application report are available in an Excel<sup>TM</sup> calculator. *What You Need To Know About Transimpedance Amplifiers – Part 1* provides a link to the calculator.

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(1)

### **Typical Application (continued)**

The equations and calculators in the referenced application report and blog posts are used to model the bandwidth ( $f_{-3dB}$ ) and noise ( $I_{RN}$ ) performance of the OPA859 configured as a TIA. The resultant performance is shown in Figure 58 and Figure 59. The left-side Y-axis shows the closed-loop bandwidth performance, whereas the right side of the graph shows the integrated input-referred noise. The noise bandwidth to calculate  $I_{RN}$  for a fixed  $R_F$  and  $C_{PD}$  is set equal to the  $f_{-3dB}$  frequency. Figure 58 shows the amplifier performance as a function of photodiode capacitance ( $C_{PD}$ ) for  $R_F = 10 \ k\Omega$  and 20  $k\Omega$ . Increasing  $C_{PD}$  decreases the closed-loop bandwidth. To maximize bandwidth, make sure to reduce any stray parasitic capacitance from the PCB. The OPA859 is designed with 0.8 pF of total input capacitance to minimize the effect of stray capacitance on system performance. Figure 59 shows the amplifier performance as a function of  $R_F$  for  $C_{PD} = 1$  pF and 2 pF. Increasing  $R_F$  results in lower bandwidth. To maximize the signal-to-noise ratio (SNR) in an optical front-end system, maximize the gain in the TIA stage. Increasing  $R_F$  by a factor of X increases the signal level by X, but only increases the resistor noise contribution by  $\sqrt{X}$ , thereby improving SNR.

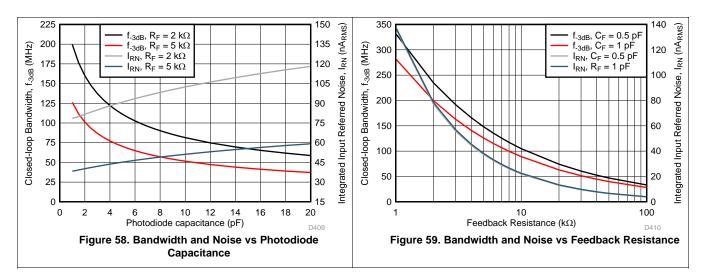
The OPA859 configured as a unity-gain buffer drives a dc offset voltage of 2.95 V into the lower half of the THS4520. To maximize the dynamic range of the ADC, the two OPA859 amplifiers drive a differential commonmode of 3.5 V and 2.95 V into the THS4520. The dc offset voltage of the buffer amplifier can be derived using Equation 1.

$$V_{BUF\_DC} = V_{TIA\_CM} - \left(\frac{1}{2} \times \frac{V_{ADC\_DIFF\_IN}}{\left(\frac{R_F}{R_G}\right)}\right)$$

where

- $V_{TIA CM}$  is the common-mode voltage of the TIA (3.5 V)
- V<sub>ADC DIFF IN</sub> is the differential input voltage range of the ADC (1.1 V<sub>PP</sub>)
- $R_F$  and  $R_G$  are the feedback resistance (499  $\Omega$ ) and gain resistance (499  $\Omega$ ) of the THS4520 differential amplifier

The low-pass filter between the THS4520 and the ADC54J64 minimizes high-frequency noise and maximizes SNR. The ADC54J64 has an internal buffer that isolates the output of the THS4520 from the ADC sampling-capacitor input, so a traditional charge bucket filter is not required.



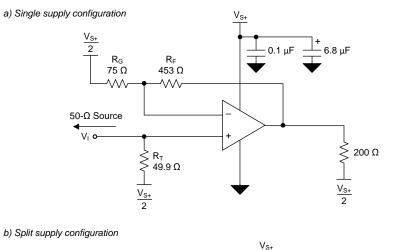
#### 10.2.3 Application Curves



#### OPA859 SBOS852 – SEPTEMBER 2018

# 11 Power Supply Recommendations

The OPA859 operates on supplies from 3.3 V to 5.25 V. The OPA859 operates on single-sided supplies, split and balanced bipolar supplies, and unbalanced bipolar supplies. Because the OPA859 does not feature rail-to-rail inputs or outputs, the input common-mode and output swing ranges are limited at 3.3-V supplies.



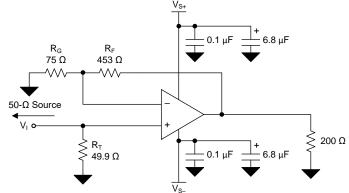


Figure 60. Split and Single Supply Circuit Configuration , Gain = 7 V/V



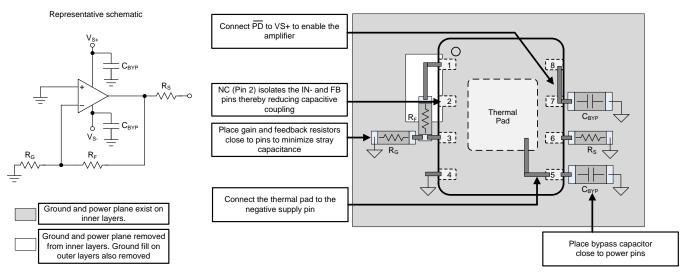
## 12 Layout

#### 12.1 Layout Guidelines

Achieving optimum performance with a high-frequency amplifier like the OPA859 requires careful attention to board layout parasitics and external component types. Recommendations that optimize performance include:

- Minimize parasitic capacitance from the signal I/O pins to ac ground. Parasitic capacitance on the output
  and inverting input pins can cause instability. To reduce unwanted capacitance, cut out the power and ground
  traces under the signal input and output pins. Otherwise, ground and power planes must be unbroken
  elsewhere on the board. When configuring the amplifier as a TIA, if the required feedback capacitor is less
  than 0.15 pF, consider using two series resistors, each of half the value of a single resistor in the feedback
  loop to minimize the parasitic capacitance from the resistor.
- Minimize the distance (less than 0.25") from the power-supply pins to high-frequency bypass capacitors. Use high-quality, 100-pF to 0.1-μF, COG and NPO-type decoupling capacitors with voltage ratings at least three times greater than the amplifiers maximum power supplies. This configuration makes sure that there is a low-impedance path to the amplifiers power-supply pins across the amplifiers gain bandwidth specification. At the device pins, do not allow the ground and power plane layout to be in close proximity to the signal I/O pins. Avoid narrow power and ground traces to minimize inductance between the pins and the decoupling capacitors. The power-supply connections must always be decoupled with these capacitors. Larger (2.2-μF to 6.8-μF) decoupling capacitors that are effective at lower frequency must be used on the supply pins. Place these decoupling capacitors further from the device. Share the decoupling capacitors among several devices in the same area of the printed circuit board (PCB).
- Careful selection and placement of external components preserves the high-frequency performance of the OPA859. Use low-reactance resistors. Surface-mount resistors work best and allow a tighter overall layout. Never use wirewound resistors in a high-frequency application. Because the output pin and inverting input pin are the most sensitive to parasitic capacitance, always position the feedback and series output resistor, if any, as close to the output pin as possible. Place other network components (such as noninverting input termination resistors) close to the package. Even with a low parasitic capacitance shunting the external resistors, high resistor values create significant time constants that can degrade performance. When configuring the OPA859 as a voltage amplifier, keep resistor values as low as possible and consistent with load driving considerations. Decreasing the resistor values keeps the resistor noise terms low and minimizes the effect of the parasitic capacitance. However, lower resistor values increase the dynamic power consumption because R<sub>F</sub> and R<sub>G</sub> become part of the output load network of the amplifier.

#### 12.2 Layout Example







## **13** Device and Documentation Support

#### 13.1 Device Support

#### 13.1.1 Development Support

- Wide Bandwidth Optical Front-end Reference Design
- LIDAR-Pulsed Time-of-Flight Reference Design Using High-Speed Data Converters
- LIDAR Pulsed Time of Flight Reference Design

### **13.2 Documentation Support**

#### 13.2.1 Related Documentation

For related documentation see the following:

- OPA858EVM User's Guide
- Transimpedance Considerations for High-Speed Amplifiers Application Report
- What You Need To Know About Transimpedance Amplifiers Part 1
- What You Need To Know About Transimpedance Amplifiers Part 2
- Training Video: How to Design Transimpedance Amplifier Circuits
- Training Video: High-Speed Transimpedance Amplifier Design Flow
- Training Video: How to Convert a TINA-TI Model into a Generic SPICE Model

#### 13.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### **13.4 Community Resources**

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

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**Design Support TI's Design Support** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 13.5 Trademarks

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#### **13.6 Electrostatic Discharge Caution**



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

SESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 13.7 Glossary

#### SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.



# 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



6-Feb-2020

# PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
OPA859IDSGR	ACTIVE	WSON	DSG	8	3000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	859	Samples
OPA859IDSGT	ACTIVE	WSON	DSG	8	250	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	859	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

6-Feb-2020

# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA859IDSGR	WSON	DSG	8	3000	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2
OPA859IDSGT	WSON	DSG	8	250	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2

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# PACKAGE MATERIALS INFORMATION

15-Sep-2018



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA859IDSGR	WSON	DSG	8	3000	210.0	185.0	35.0
OPA859IDSGT	WSON	DSG	8	250	210.0	185.0	35.0

# DSG 8

2 x 2, 0.5 mm pitch

# **GENERIC PACKAGE VIEW**

# WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





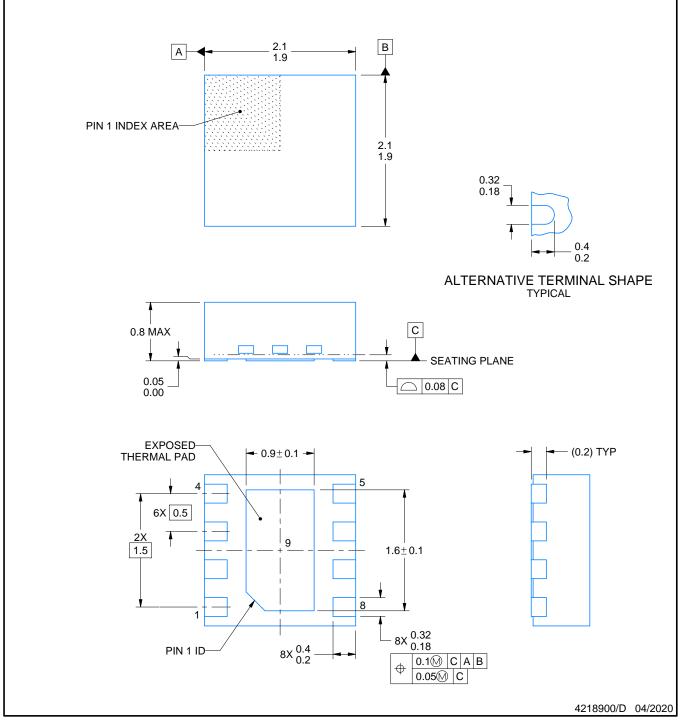
# DSG0008A



# **PACKAGE OUTLINE**

# WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.

3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

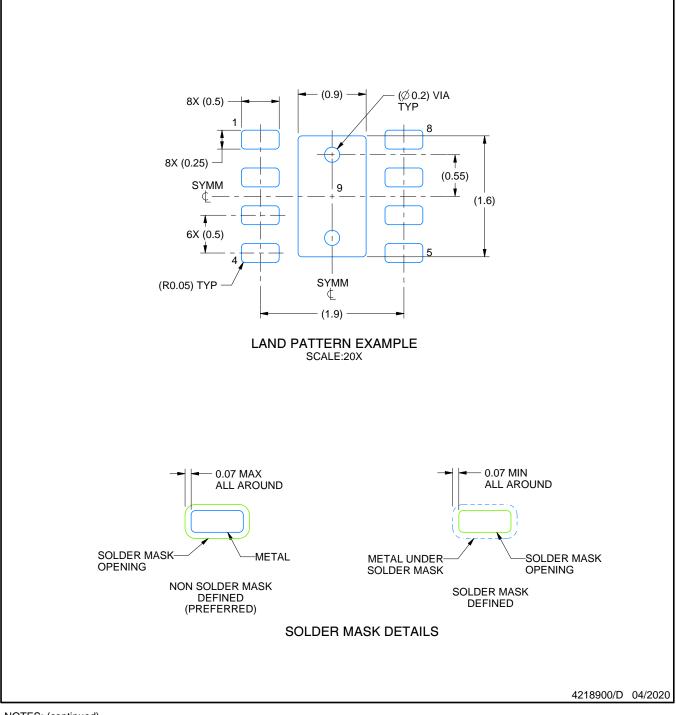


# DSG0008A

# **EXAMPLE BOARD LAYOUT**

# WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

 Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

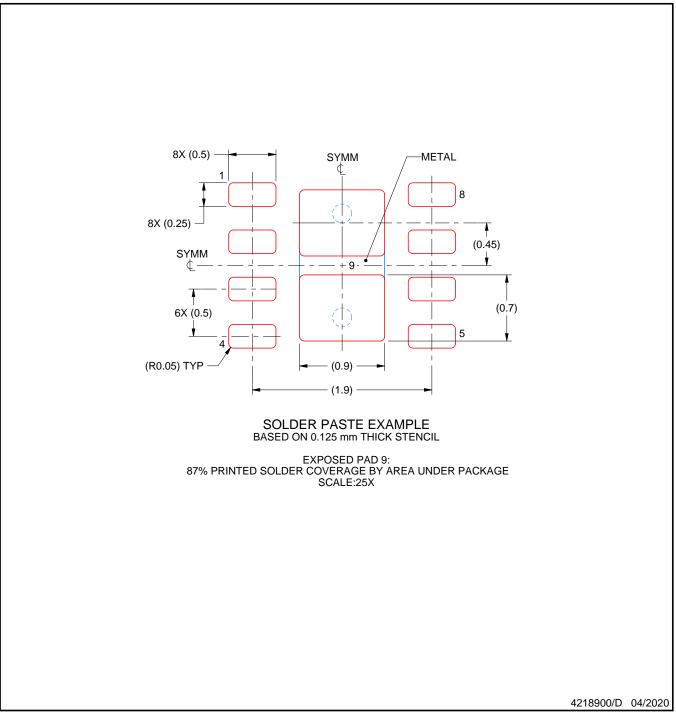


# DSG0008A

# **EXAMPLE STENCIL DESIGN**

# WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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